

# Reference Voltage Generation Circuit Insensitive to Temperature

Lei Sha, Anna Kuwana, Haruo Kobayashi

Division of Electronics and Informatics, Gunma University, Japan

Email: t191d031@gunma-u.ac.jp



## 1. Research Objective

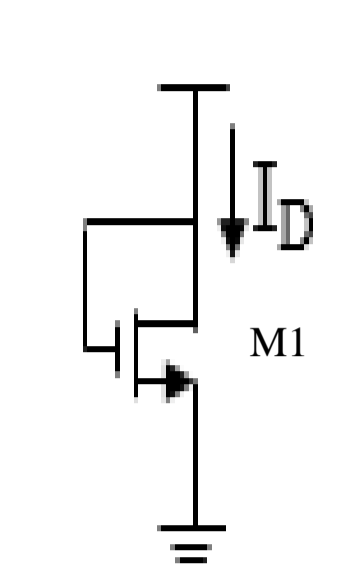
- Analog IC requires
  - Operation in wide temperature range
  - One voltage reference



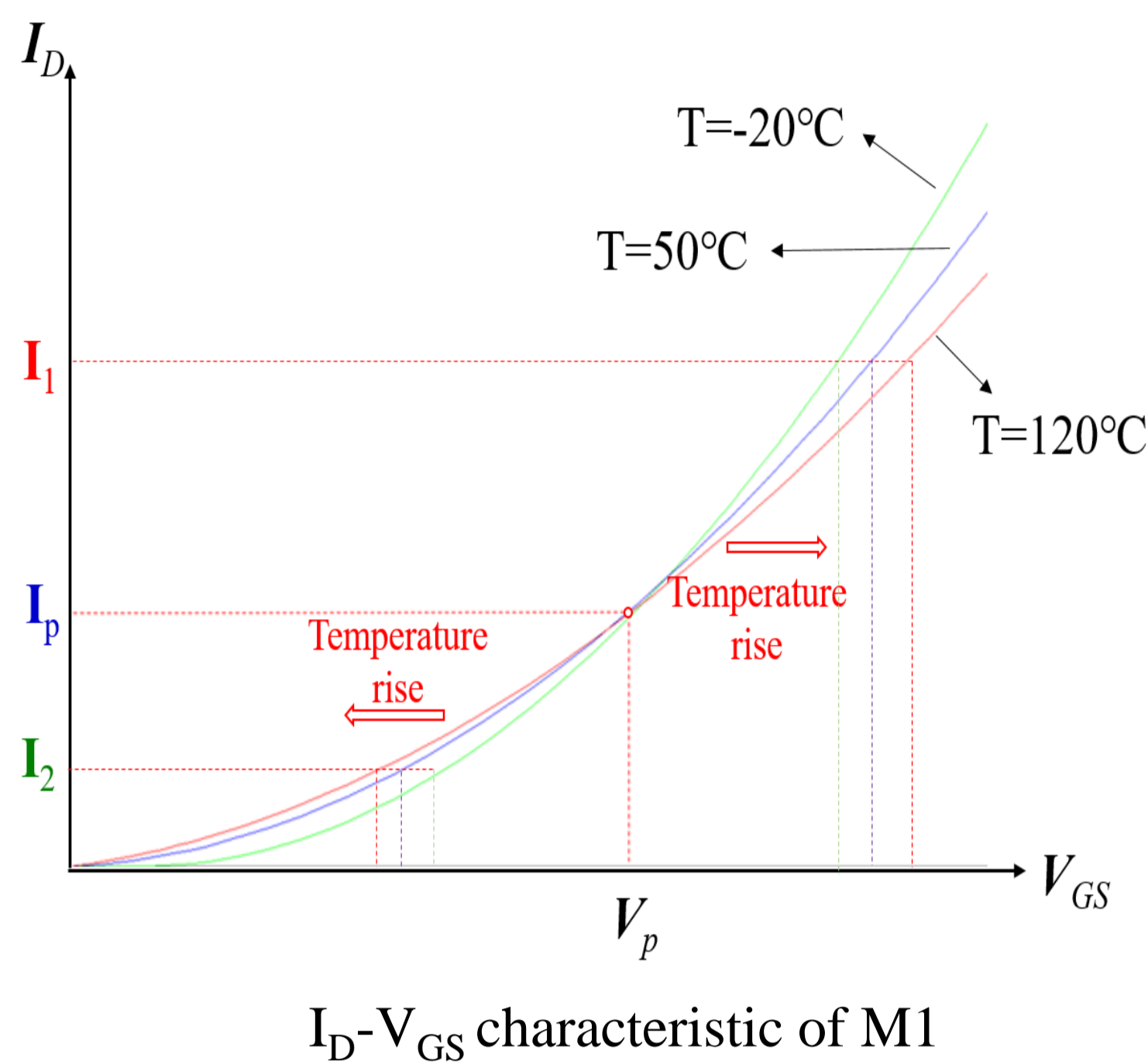
Proposed a reference voltage generator

- Insensitive to temperature
- Simple
- Based on MOS temperature characteristics

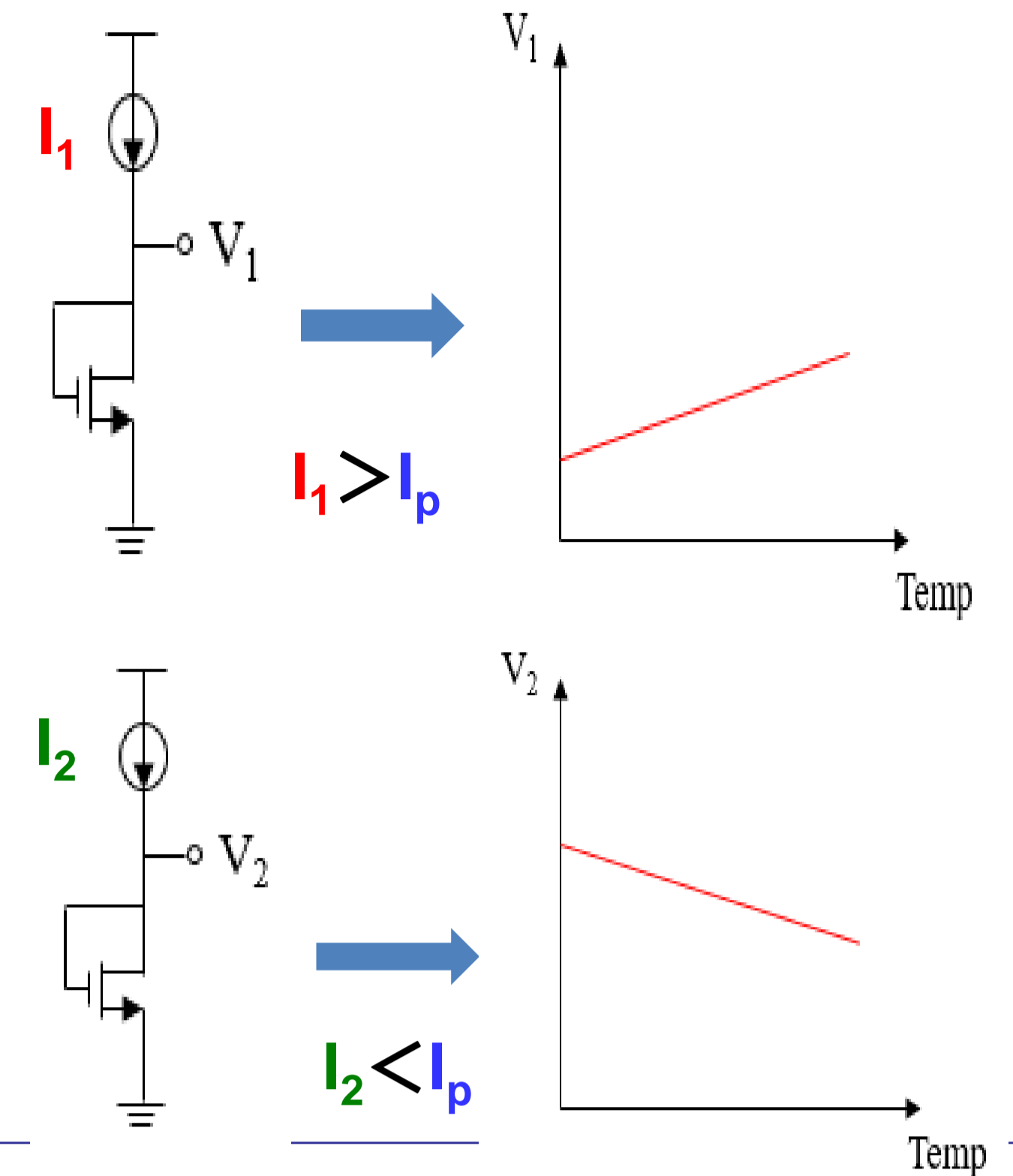
## 2. Point of Our Work



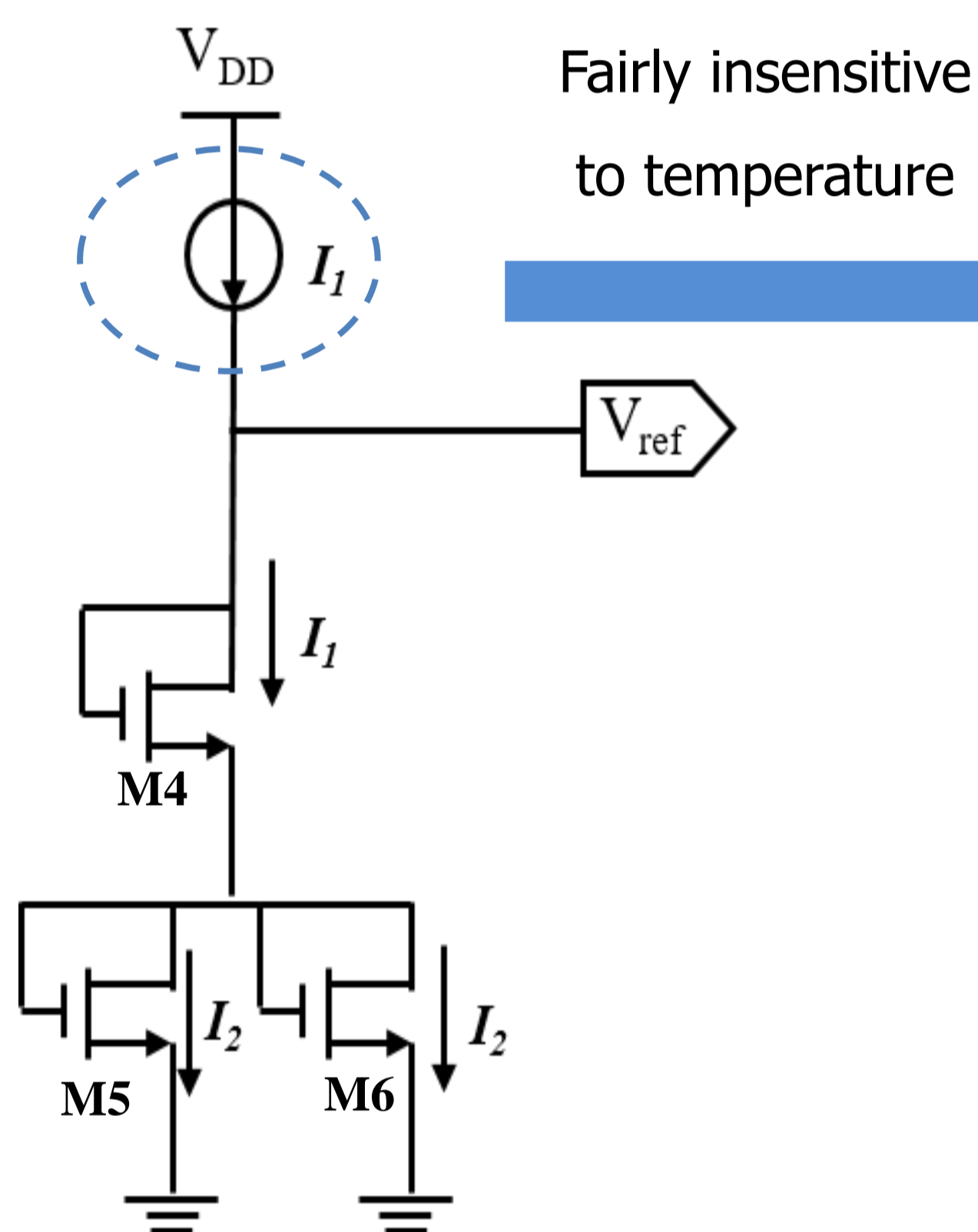
Drain-Gate connected NMOS



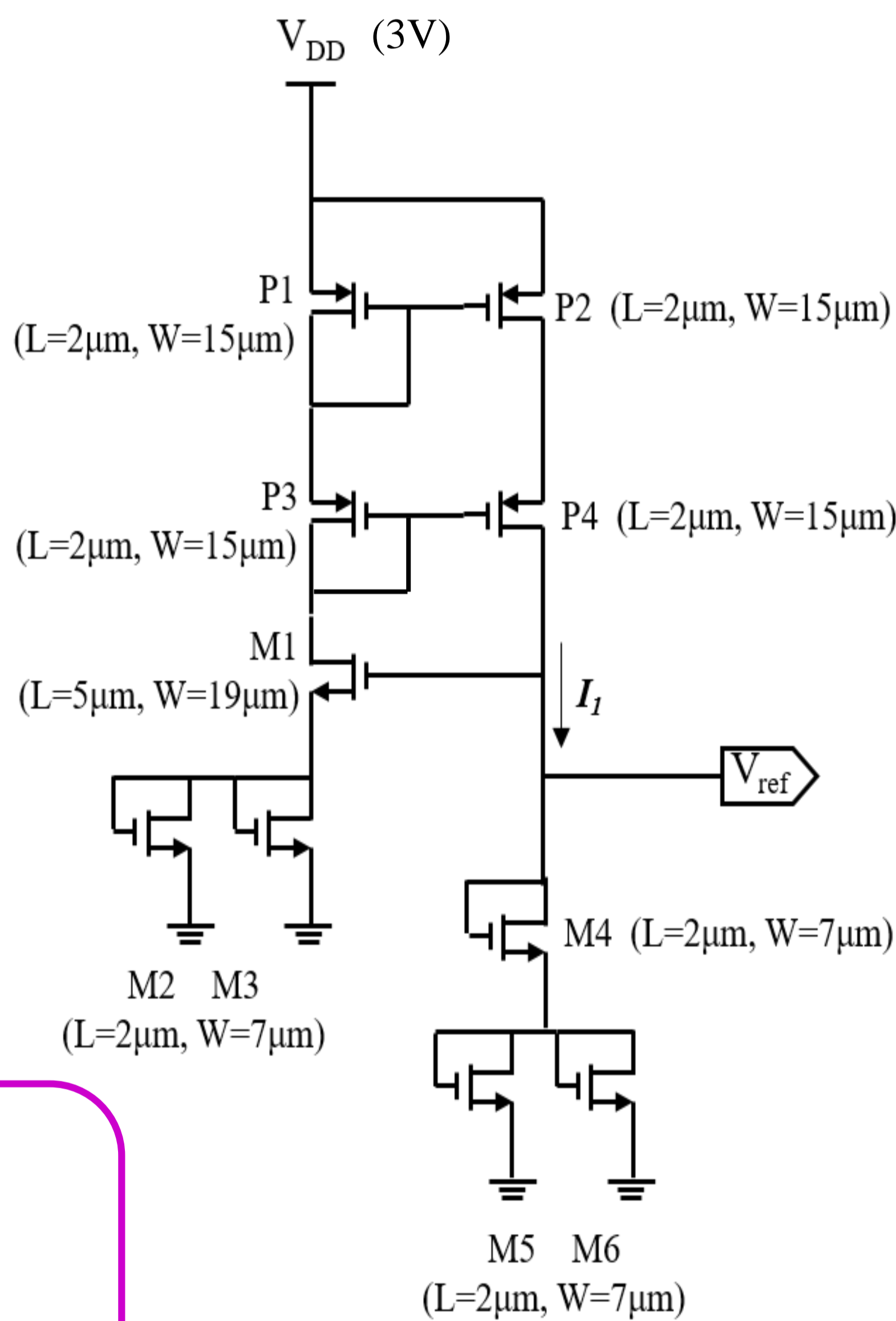
### Temperature characteristics of NMOSFET



## 3. Proposed Circuit



- Large current ( $I_1$ ) through M4
  - Small current ( $I_2$ ) through M5, M6
- Two gate-source voltages are added
- Temperature characteristics are cancelled.

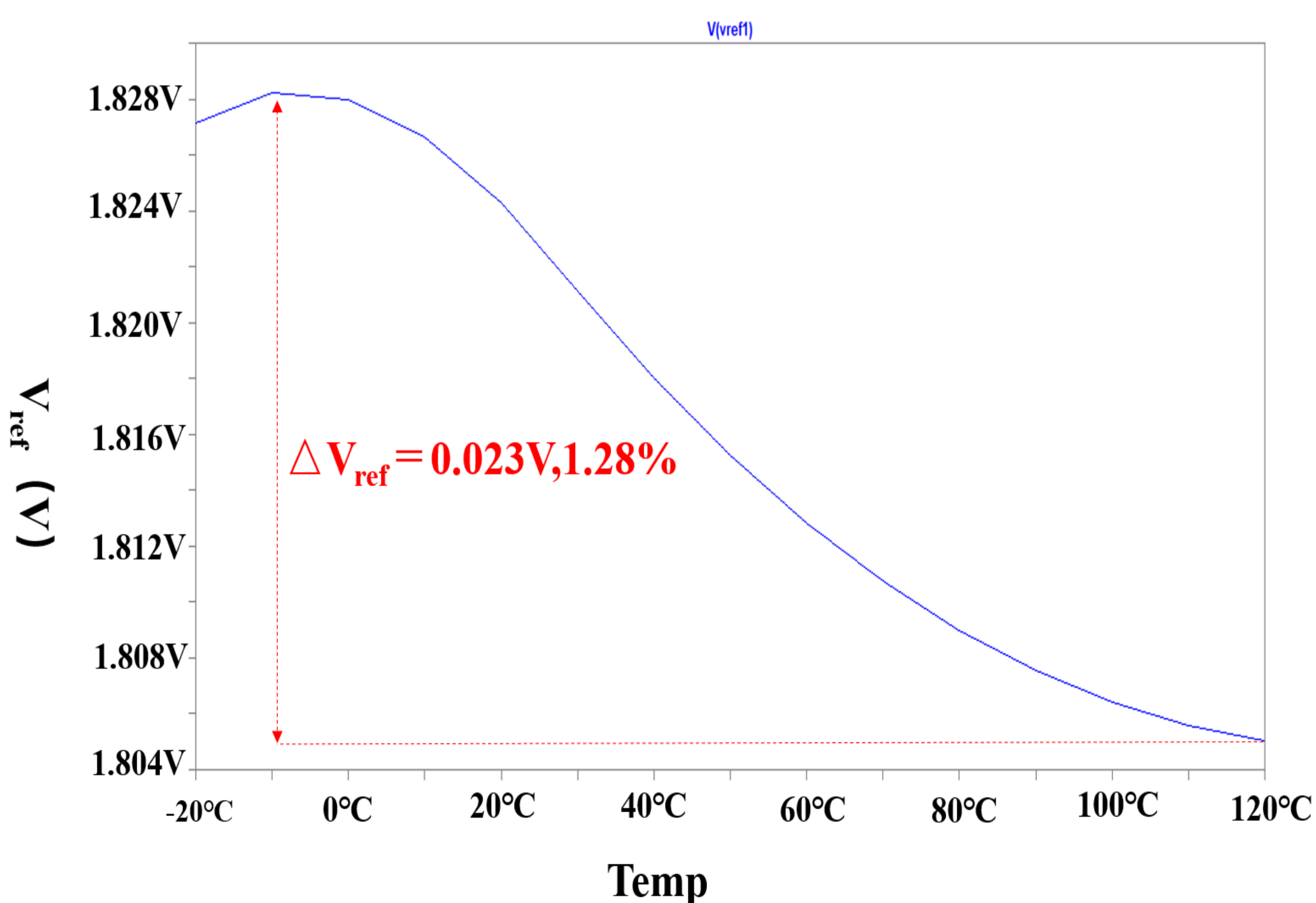


As temperature becomes high

- $I_1 > I_p$ , gate-source voltage increases
- $I_2 < I_p$ , gate-source voltage decreases

- P1, P2, P3, P4, M1, M2, M3 compose a constant current source
- Utilizing M2, M3 for current source
- M4, M5, M6 are used to compensate for temperature sensitivity of  $V_{ref}$ .

## 4. SPICE Simulation Result



Supply voltage = 3V

😊 Small temperature coefficient

## 5. Conclusion

- Small reference voltage deviation
  - ➔ 0.017V from -20°C to 120°C for supply voltage of 3V.
- Next step: focus on supply voltage
  - ➔ Make reference voltage insensitive to power supply voltage.

## References

- [1] I. Lee, D. Blaauw, "A 31 pW-to-113nW Hybrid BJT and CMOS Voltage Reference with 3.6%  $\pm 3\delta$ -inaccuracy from 0°C to 170°C for Low-Power High-Temperature IoT Systems", VLSI Circuit Symp (2019)
- [2] T. Ida, N. Tsukiji, Y. Shibasaki, A. Kuwana, H. Kobayashi, "MOS Reference Current Source Insensitive to Temperature Variation", ICMEMIS, Kiryu (Nov. 2018)